SHIGA7.040APC PATENT

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Hayashi et al.

Appl. No. : 10/561,830

Filed : December 22, 2005

For : POSITIVE RESIST

COMPOSITION AND METHOD

OF FORMING RESIST PATTERN

USING SAME

Examiner : Eoff, Anca

Group Art Unit : 1795

## SUBMISSION WITH RCE

## Mail Stop Amendment

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In response to the final Office Action mailed **June 2, 2009**, please consider the following amendments and remarks:

Amendments to the claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks/Arguments begin on page 4 of this paper.